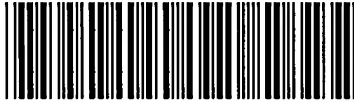


Search Notes

Application/Control No.

10/659,307

Examiner

Cong-Lac Huynh

Applicant(s)/Patent under
Reexamination

TANAKA ET AL.

Art Unit

2178

SEARCHED

Class	Subclass	Date	Examiner
715	500	5/18/2007	CLH
	500.1	6/1/2007	CLH
	722	6/1/2007	CLH
	723	6/1/2007	CLH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
East	6/1/2007	CLH
ACM	6/1/2007	CLH